

Notice of References Cited	Application/Control No. 10/743,850		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner DAVID CZEKAJ		Art Unit 2621	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,079,583	07-2006	Yoshioka et al.	375/240.26
*	B	US-2003/0185298	10-2003	Alvarez et al.	375/240.03
*	C	US-5,802,063	09-1998	Deiss, Michael Scott	370/476
*	D	US-6,847,656	01-2005	Wu et al.	370/477
*	E	US-6,792,047	09-2004	Bixby et al.	375/240.26
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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